



Up to 6 GHz Medium Power Silicon Bipolar Transistor

Technical Data

AT-42010

Features

- **High Output Power:**
12.0 dBm Typical $P_{1\text{ dB}}$ at 2.0 GHz
20.5 dBm Typical $P_{1\text{ dB}}$ at 4.0 GHz
- **High Gain at
1 dB Compression:**
14.0 dB Typical $G_{1\text{ dB}}$ at 2.0 GHz
9.5 dB Typical $G_{1\text{ dB}}$ at 4.0 GHz
- **Low Noise Figure:**
1.9 dB Typical NF_0 at 2.0 GHz
- **High Gain-Bandwidth
Product:** 8.0 GHz Typical f_T
- **Hermetic Gold-ceramic
Microstrip Package**

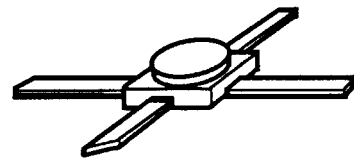
Description

Agilent's AT-42010 is a general purpose NPN bipolar transistor that offers excellent high frequency performance. The AT-42010 is housed in a hermetic, high reliability 100 mil ceramic package. The 4 micron emitter-to-emitter pitch enables this transistor to be used in many different

functions. The 20 emitter finger interdigitated geometry yields a medium sized transistor with impedances that are easy to match for low noise and medium power applications. This device is designed for use in low noise, wideband amplifier, mixer and oscillator applications in the VHF, UHF, and microwave frequencies. An optimum noise match near $50\ \Omega$ up to 1 GHz, makes this device easy to use as a low noise amplifier.

The AT-42010 bipolar transistor is fabricated using Agilent's 10 GHz f_T Self-Aligned-Transistor (SAT) process. The die is nitride passivated for surface protection. Excellent device uniformity, performance and reliability are produced by the use of ion-implantation, self-alignment techniques, and gold metalization in the fabrication of this device.

100 mil Package



AT-42010 Absolute Maximum Ratings^[1]

Symbol	Parameter	Units	Absolute Maximum
V_{EBO}	Emitter-Base Voltage	V	1.5
V_{CBO}	Collector-Base Voltage	V	20
V_{CEO}	Collector-Emitter Voltage	V	12
I_C	Collector Current	mA	80
P_T	Power Dissipation ^[2,3]	mW	600
T_j	Junction Temperature	°C	200
T_{STG}	Storage Temperature	°C	-65 to 200

Thermal Resistance^[2,4]:

$$\theta_{jc} = 150^\circ\text{C/W}$$

Notes:

1. Permanent damage may occur if any of these limits are exceeded.
2. $T_{CASE} = 25^\circ\text{C}$.
3. Derate at 6.7 mW/°C for $T_C > 110^\circ\text{C}$.
4. The small spot size of this technique results in a higher, though more accurate determination of θ_{jc} than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

Electrical Specifications, $T_A = 25^\circ\text{C}$

Symbol	Parameters and Test Conditions ^[1]	Units	Min.	Typ.	Max.
$ S_{21E} ^2$	Insertion Power Gain; $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$	$f = 2.0\text{ GHz}$ $f = 4.0\text{ GHz}$	dB	10.5	11.5 5.5
$P_{1\text{ dB}}$	Power Output @ 1 dB Gain Compression $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$	$f = 2.0\text{ GHz}$ $f = 4.0\text{ GHz}$	dBm		21.0 20.5
$G_{1\text{ dB}}$	1 dB Compressed Gain; $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$	$f = 2.0\text{ GHz}$ $f = 4.0\text{ GHz}$	dB		14.0 9.5
NF_O	Optimum Noise Figure; $V_{CE} = 8\text{ V}$, $I_C = 10\text{ mA}$	$f = 2.0\text{ GHz}$ $f = 4.0\text{ GHz}$	dB		1.9 3.0
G_A	Gain @ NF_O ; $V_{CE} = 8\text{ V}$, $I_C = 10\text{ mA}$	$f = 2.0\text{ GHz}$ $f = 4.0\text{ GHz}$	dB		13.5 10.0
f_T	Gain Bandwidth Product; $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$		GHz		8.0
h_{FE}	Forward Current Transfer Ratio; $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$		—	30	150
I_{CBO}	Collector Cutoff Current; $V_{CB} = 8\text{ V}$		μA		0.2
I_{EBO}	Emitter Cutoff Current; $V_{EB} = 1\text{ V}$		μA		2.0
C_{CB}	Collector Base Capacitance ^[1] ; $V_{CB} = 8\text{ V}$, $f = 1\text{ MHz}$		pF	0.28	

Notes:

1. For this test, the emitter is grounded.

AT-42010 Typical Performance, $T_A = 25^\circ\text{C}$

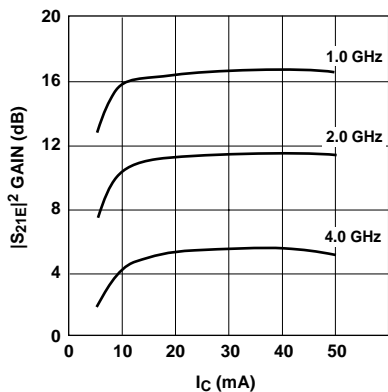


Figure 1. Insertion Power Gain vs. Collector Current and Frequency. $V_{CE} = 8\text{ V}$.

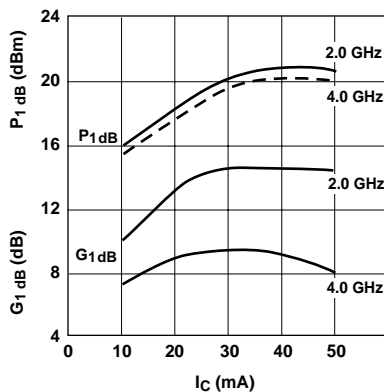


Figure 2. Output Power and 1 dB Compressed Gain vs. Collector Current and Frequency. $V_{CE} = 8\text{ V}$.

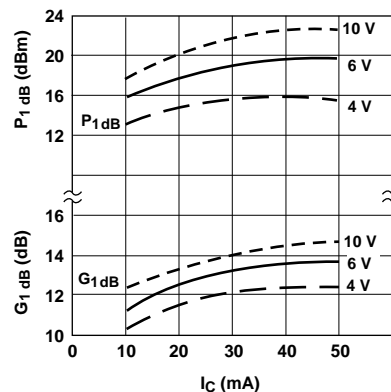


Figure 3. Output Power and 1 dB Compressed Gain vs. Collector Current and Voltage. $f = 2.0\text{ GHz}$.

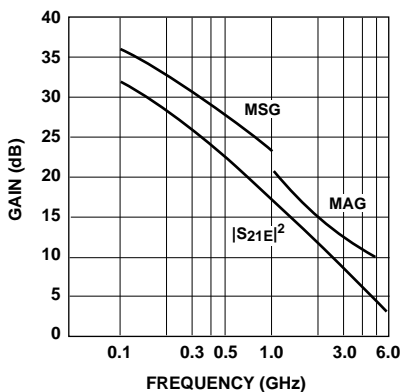


Figure 4. Insertion Power Gain, Maximum Available Gain and Maximum Stable Gain vs. Frequency. $V_{CE} = 8\text{ V}$, $I_C = 35\text{ mA}$.

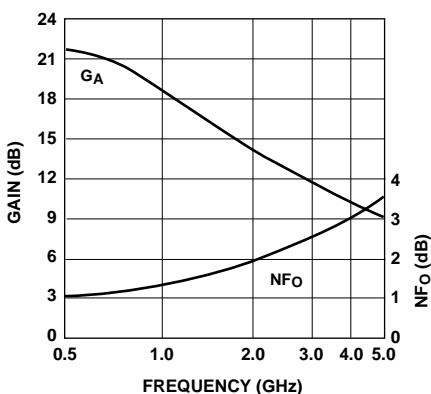


Figure 5. Noise Figure and Associated Gain vs. Frequency. $V_{CE} = 8\text{ V}$, $I_C = 10\text{ mA}$.

AT-42010 Typical Scattering Parameters, Common Emitter, $Z_O = 50 \Omega$, $T_A = 25^\circ\text{C}$, $V_{CE} = 8 \text{ V}$, $I_C = 10 \text{ mA}$

Freq. GHz	S_{11}		dB	S_{21}		dB	S_{12}		S_{22}	
	Mag.	Ang.		Mag.	Ang.		Mag.	Ang.	Mag.	Ang.
0.1	.74	-47	28.5	26.65	153	-36.4	.015	72	.91	-18
0.5	.65	-136	21.4	11.71	103	-29.4	.034	38	.51	-39
1.0	.63	-168	15.9	6.24	82	-27.2	.044	36	.40	-42
1.5	.63	174	12.6	4.26	69	-26.0	.050	42	.38	-45
2.0	.63	161	10.1	3.23	57	-24.6	.059	43	.38	-49
2.5	.64	154	8.4	2.64	51	-23.0	.070	52	.38	-51
3.0	.65	145	6.9	2.22	41	-22.0	.080	54	.37	-56
3.5	.66	136	5.8	1.94	31	-21.0	.090	51	.38	-65
4.0	.66	126	4.7	1.72	21	-19.7	.104	50	.39	-74
4.5	.66	115	3.8	1.55	11	-18.0	.126	45	.40	-82
5.0	.66	103	3.0	1.41	1	-17.3	.136	41	.40	-89
5.5	.68	90	2.1	1.28	-9	-16.1	.156	36	.40	-98
6.0	.72	81	1.3	1.16	-19	-15.4	.170	31	.37	-110

AT-42010 Typical Scattering Parameters,Common Emitter, $Z_O = 50 \Omega$, $T_A = 25^\circ\text{C}$, $V_{CE} = 8 \text{ V}$, $I_C = 35 \text{ mA}$

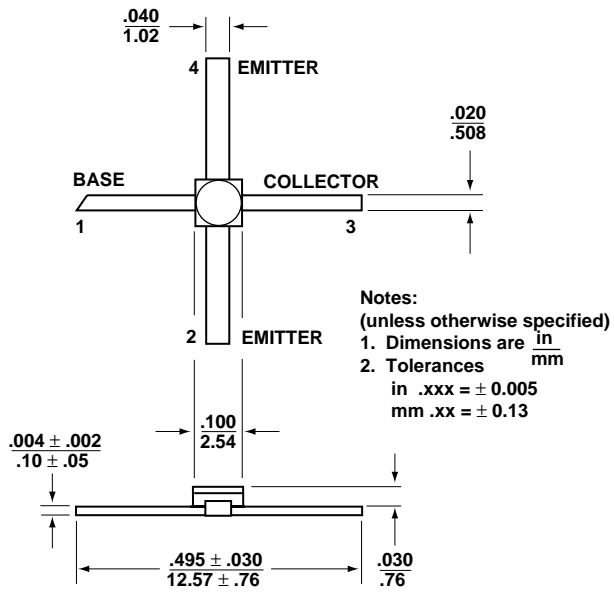
Freq. GHz	S_{11}		dB	S_{21}		dB	S_{12}		S_{22}	
	Mag.	Ang.		Mag.	Ang.		Mag.	Ang.	Mag.	Ang.
0.1	.54	-90	33.3	45.97	138	-39.2	.011	54	.76	-29
0.5	.62	-163	22.8	13.83	94	-33.2	.022	52	.34	-40
1.0	.62	177	17.0	7.10	78	-28.8	.036	59	.30	-40
1.5	.62	166	13.6	4.82	67	-26.2	.049	61	.29	-42
2.0	.62	155	11.3	3.65	56	-23.8	.065	57	.29	-47
2.5	.63	150	9.5	2.99	51	-21.8	.081	62	.29	-50
3.0	.64	142	8.0	2.52	42	-21.0	.090	63	.30	-57
3.5	.65	133	6.8	2.19	32	-19.7	.103	59	.30	-67
4.0	.65	124	5.7	1.93	22	-18.4	.120	54	.31	-76
4.5	.65	113	4.7	1.72	13	-17.2	.138	49	.33	-85
5.0	.66	102	3.9	1.56	3	-16.6	.148	45	.34	-92
5.5	.69	91	3.0	1.41	-6	-15.6	.166	39	.33	-100
6.0	.73	83	2.1	1.27	-16	-14.9	.180	32	.30	-110

A model for this device is available in the DEVICE MODELS section.

AT-42010 Noise Parameters: $V_{CE} = 8 \text{ V}$, $I_C = 10 \text{ mA}$

Freq. GHz	NF_O dB	Γ_{opt}		$R_N/50$
		Mag	Ang	
0.1	1.0	.04	15	0.13
0.5	1.1	.05	76	0.12
1.0	1.5	.10	132	0.12
2.0	1.9	.23	-177	0.11
4.0	3.0	.45	-125	0.26

100 mil Package Dimensions





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